

DCR3790B42



Phase Control Thyristor

Preliminary Information

DS5809-1.2 May 2009 (LN26739)

FEATURES

- Double Side Cooling
- High Surge Capability

APPLICATIONS

- High Power Drives
- High Voltage Power Supplies
- Static Switches

VOLTAGE RATINGS

Part and Ordering Number	Repetitive Peak Voltages V _{DRM} and V _{RRM} V	Conditions
DCR3790B42 DCR3790B40 DCR3790B35 DCR3790B30	4200 4000 3500 3000	$ \begin{split} T_{vj} &= -40 \ \mbox{°C} \ to \ 125 \ \mbox{°C}, \\ I_{DRM} &= I_{RRM} = 200 \ \mbox{mA}, \\ V_{DRM}, V_{RRM} \ t_p &= 10 \ \mbox{ms}, \\ V_{DSM} \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$

Lower voltage grades available.

ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

DCR3790B42

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

KEY PARAMETERS

V _{DRM}	4200V
I _{T(AV)}	3790A
I _{TSM}	53500A
dV/dt*	1500V/μs
dI/dt	400A/μs

* Higher dV/dt selections available

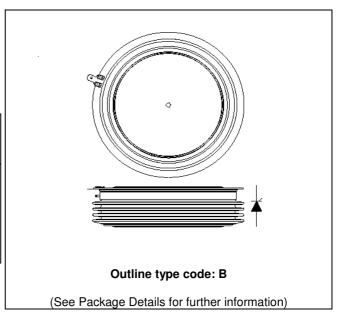


Fig. 1 Package outline



CURRENT RATINGS

 T_{case} = 60 °C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Double Si	de Cooled			
I _{T(AV)}	Mean on-state current	Half wave resistive load	3790	А
I _{T(RMS)}	RMS value	-	5953	А
Ι _Τ	Continuous (direct) on-state current	-	5330	А

SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
I _{TSM}	Surge (non-repetitive) on-state current	10ms half sine, $T_{case} = 125 \degree C$	53.5	kA
l ² t	I ² t for fusing	$V_{R} = 0$	14.31	MA ² s

THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Condition	Min.	Max.	Units	
R _{th(j-c)}	Thermal resistance – junction to case	Double side cooled DC		-	0.007	℃/W
		Single side cooled	Anode DC	-	0.0116	℃/W
			Cathode DC	-	0.0181	°C/W
R _{th(c-h)}	Thermal resistance – case to heatsink	Clamping force 70.0kN	Double side	-	0.0014	°C/W
		(with mounting compound)	Single side	-	0.0028	°C/W
T_{vj}	Virtual junction temperature	On-state (conducting)		-	135	°C
		Reverse (blocking)		-	125	°C
T _{stg}	Storage temperature range			-55	125	°C
Fm	Clamping force			63.0	77.0	kN



DYNAMIC CHARACTERISTICS

Symbol	Parameter	Test Conditio	Min.	Max.	Units	
I _{RRM} /I _{DRM}	Peak reverse and off-state current	At V _{RRM} /V _{DRM} , T _{case} = 125 °C		-	200	mA
dV/dt	Max. linear rate of rise of off-state voltage	To 67% V _{DRM} , T _j = 125 °C, ga	ate open	-	1500	V/µs
dl/dt	Rate of rise of on-state current	From 67% V_{DRM} to 2x $I_{\text{T}(\text{AV})}$	Repetitive 50Hz	-	200	A/µs
		Gate source 30V, 10Ω ,	Non-repetitive	-	400	A/µs
		t _r < 0.5µs, T _j = 125 ℃				
V _{T(TO)}	Threshold voltage – Low level	700A to 4100A at $T_{case} = 125$	5℃	-	0.83	V
	Threshold voltage – High level	4100A to 12000A at T _{case} = 125 °C		-	1.0	V
r _T	On-state slope resistance – Low level	700A to 4100A at T _{case} = 125 ℃		-	0.1688	mΩ
	On-state slope resistance – High level	4100A to 12000A at T _{case} = 125 ℃		-	0.1263	mΩ
t _{gd}	Delay time	$V_D = 67\% V_{DRM}$, gate source 30V, 10 Ω		TBD	TBD	μs
		$t_r = 0.5 \mu s, T_j = 25 \ ^{\circ}C$				
t _q	Turn-off time	$T_j = 125 ^{\circ}C, V_R = 200V, dl/dt = 1A/\mu s,$		250	500	μs
		$dV_{DR}/dt = 20V/\mu s$ linear				
Qs	Stored charge	I_T = 2000A, T_j = 125 °C, dI/dt – 1A/µs,		1500	4500	μC
ΙL	Latching current	$T_j = 25 ^{\circ}\text{C}, V_D = 5\text{V}$		-	3	А
Ι _Η	Holding current	$T_j = 25 ^{\circ}C, R_{G-K} = \infty, I_{TM} = 50$	0A, I _T = 5A	-	300	mA



GATE TRIGGER CHARACTERISTICS AND RATINGS

Symbol	Parameter Test Conditions		Max.	Units
V _{GT}	Gate trigger voltage	$V_{DRM} = 5V, T_{case} = 25 \ ^{\circ}C$	1.5	V
V_{GD}	Gate non-trigger voltage	At 50% V _{DRM,} T _{case} = 125 ℃	0.4	V
I _{GT}	Gate trigger current	V _{DRM} = 5V, T _{case} = 25℃	250	mA
I _{GD}	Gate non-trigger current	At 50% V _{DRM,} T _{case} = 125 ℃	10	mA

CURVES

) ***Nex SEMICONDUCTOR

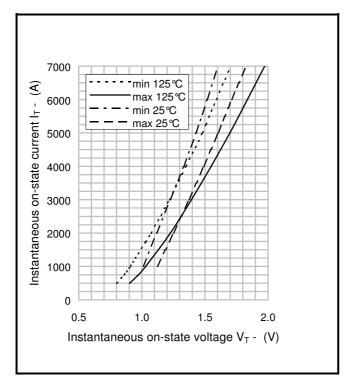


Fig.2 Maximum & minimum on-state characteristics

V_{TM} EQUATION

Where A = 0.348967B = 0.066851 $V_{TM} = A + Bln (I_T) + C.I_T + D.\sqrt{I_T}$ C = 0.000102D = 0.003788these values are valid for T_j = 125 $^{\circ}\!C$ for I_T 500A to 10000A



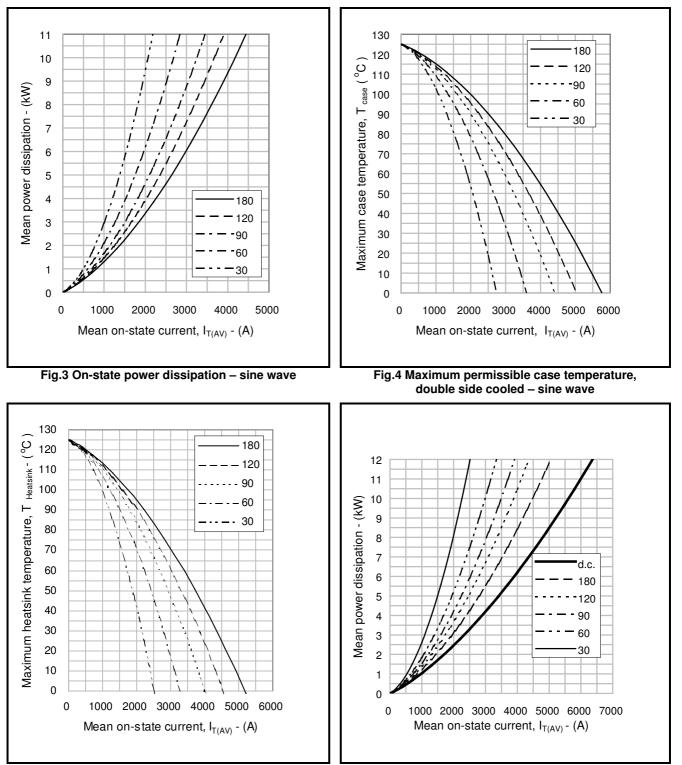
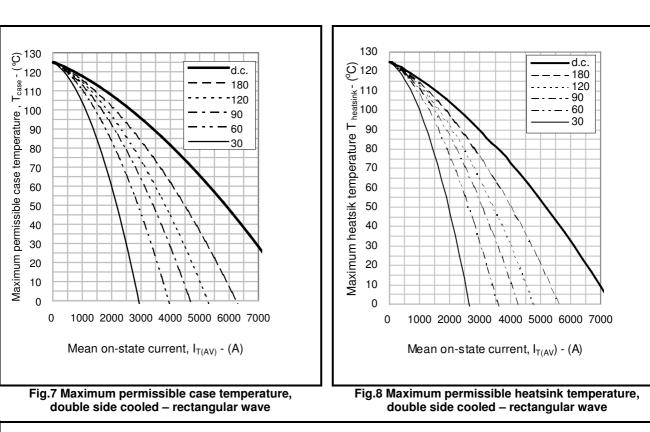


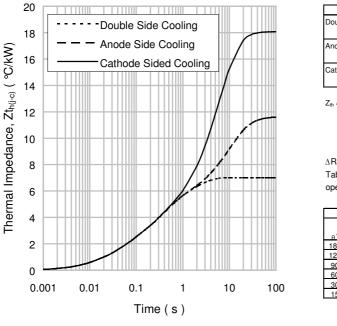
Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave

Fig.6 On-state power dissipation - rectangular wave

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		1	2	3	4
Double side cooled	R _i (℃/kW)	0.502	1.333	2.9559	2.2335
	T _i (s)	0.0137081	0.0548877	0.3311925	1.6905
Anode side cooled	R _i (℃/kW)	1.3035	3.138	1.1859	5.9136
	T _i (s)	0.0251065	0.2410256	1.0806	11.002
Cathode side cooled	R _i (℃/kW)	1.2616	2.6216	13.3603	0.8304
	T _i (s)	0.0245837	0.2005035	5.7854	16.765

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 $Z_{th} = \sum [R_i x (1-exp. (t/t_i))]$ [1]

 $\Delta \textbf{R}_{\text{th(j-c)}}$ Conduction

Tables show the increments of thermal resistance $R_{\text{th}(j\cdot c)}$ when the device operates at conduction angles other than d.c.

Double side cooling		1	Anode Side Cooling			Cathode Sided Coolin		
	ΔZ_{th}	(z)		ΔZ	_{th} (z)		ΔZ	_{th} (z)
θ°	sine.	rect.	θ°	sine.	rect.	θ°	sine.	re
180	0.70	0.48	180	0.67	0.47	180	0.67	0.4
120	0.80	0.68	120	0.77	0.66	120	0.77	0.
90	0.90	0.78	90	0.87	0.75	90	0.87	0.
60	1.00	0.89	60	0.95	0.86	60	0.95	0.
30	1.07	1.01	30	1.02	0.96	30	1.02	0.
15	1.10	1.07	15	1.05	1.02	15	1.05	1.

Fig.9 Maximum (limit) transient thermal impedance – junction to case (°C/kW)



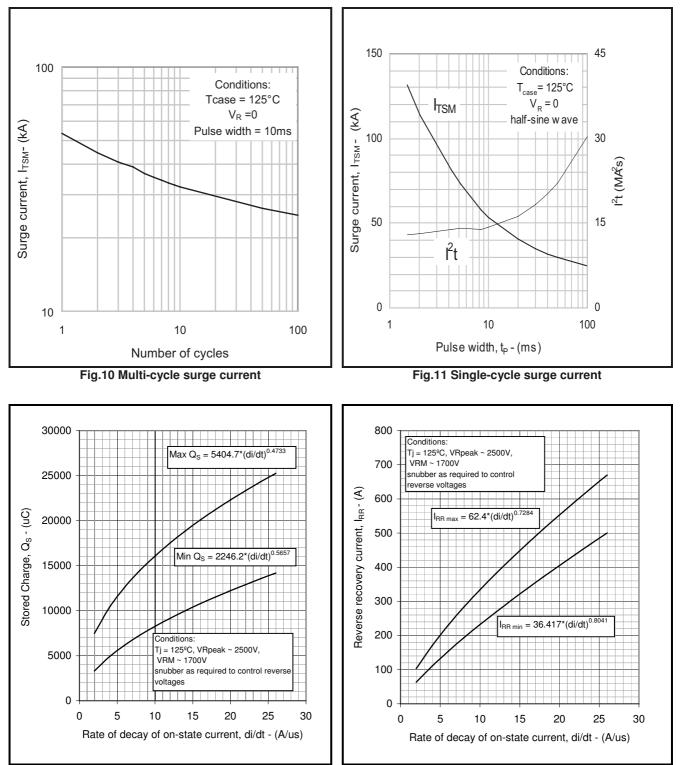


Fig.12 Stored charge

Fig.13 Reverse recovery current

@2 ion implant DCR3790B42

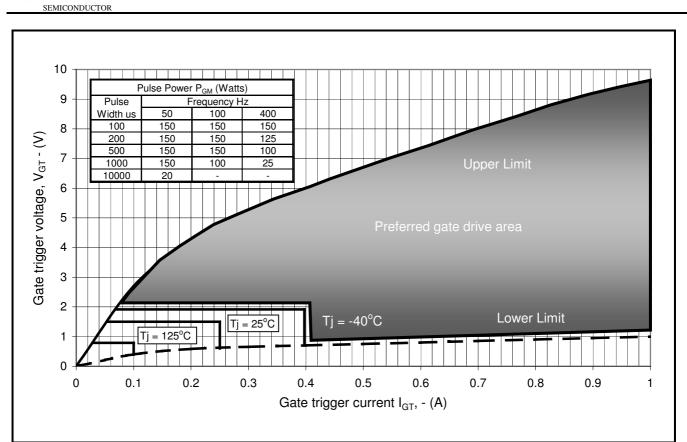


Fig14 Gate Characteristics

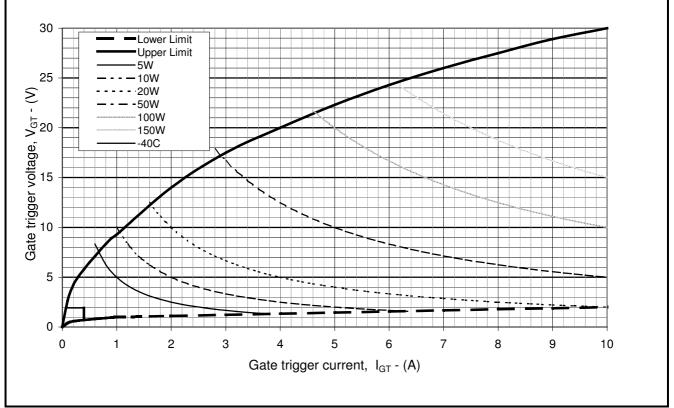


Fig. 15 Gate characteristics

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C BYNCX



@2 Ion Implant

PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

		Maximum	Minimum				
3rd ANGLE PROJECTION · · · · · · DO NOT SCALE IF IN DOUBT ASK		Thickness	Thickness				
	Device	(mm)					
HOLE Ø3.60 X 2.00	DCR5050B22	34.565	(mm) 34.115				
DEEP (IN BOTH ELECTRODES)	DCR4590B28	34.64	34.113				
	DCR3790B42	34.87 34.87	34.19 34.42				
	DCR3480B52	34.99	34.54				
20° OFFSET (NOM.)	DCR2880B65	35.25	34.8				
	DCR2400B85	35.61	34.8				
	DON2400D03	55.01	33.10				
OTEN ON AX. OTEN ON AX. OTEN ON AX. OTEN ON AX. OTEN ON AX. OTEN							
Lead length: 420mn	Clamping force: 76kN ±10% Lead length: 420mm Lead terminal connector: M4 ring						
Package outline type co	ode: B						

Fig.16 Package outline



POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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